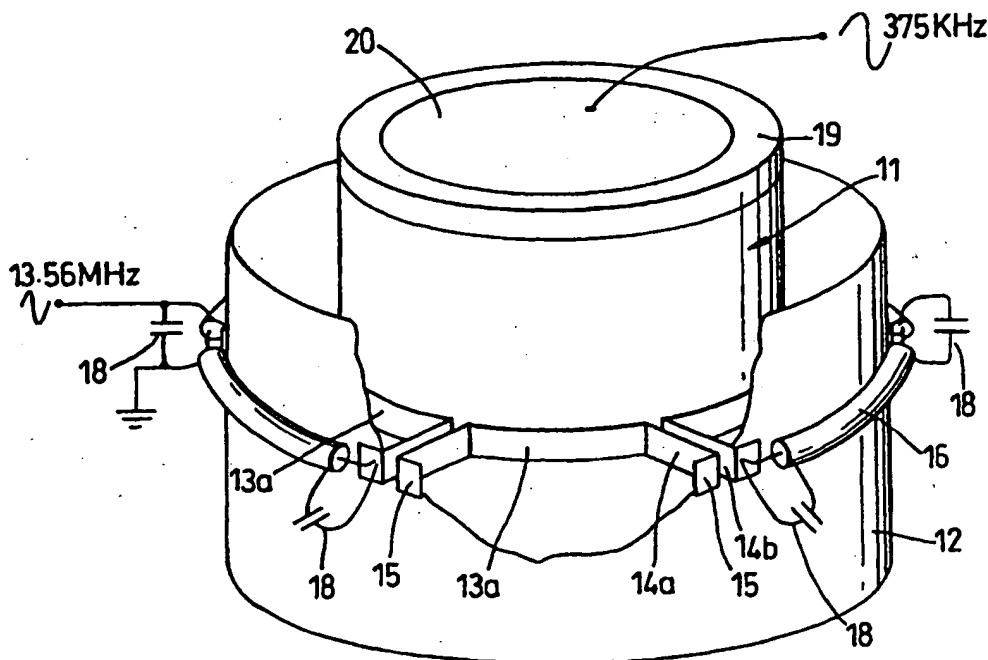


## INTERNATIONAL APPLICATION PUBLISHED UNDER THE PATENT COOPERATION TREATY (PCT)

(51) International Patent Classification <sup>7</sup> : <b>H01J 37/32</b>	<b>A2</b>	(11) International Publication Number: <b>WO 00/36632</b> (43) International Publication Date: 22 June 2000 (22.06.00)
(21) International Application Number: PCT/GB99/04280 (22) International Filing Date: 16 December 1999 (16.12.99) (30) Priority Data: 9827778.3                      17 December 1998 (17.12.98)    GB (71) Applicant (for all designated States except US): TRIKON HOLDINGS LIMITED [GB/GB]; Coed Rhedyn, Ringland Way, Newport, Gwent NP6 2TA (GB). (72) Inventor; and (75) Inventor/Applicant (for US only): BENNETT, Paul, George [GB/GB]; 6 Dighton Gate, Stoke Gifford, Bristol BS 34 (GB). (74) Agent: WYNNE-JONES, LAINE & JAMES; 22 Rodney Road, Cheltenham GL50 1JJ (GB).		(81) Designated States: DE, JP, US. Published <i>Without international search report and to be republished upon receipt of that report.</i>

(54) Title: INDUCTIVE COIL ASSEMBLY



## (57) Abstract

This invention relates to inductive coil assemblies for plasma processing apparatus. The assembly includes a coil (10) and an external screen (12). The coil is constituted by a polarity of coil portions (13) and includes respective connecting means for connecting each portion (13) in parallel with the others and to RF source, the connecting means (14a, 14b) being formed such that current flowing in any part of the coil other than a portion is balanced by current flowing in an opposite sense in an adjacent part.

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10/557695  
IAP6 Rec'd PCT/PTO 22 NOV 2005Inductive Coil Assembly

This invention relates to inductive coil assemblies for plasma processing apparatus.

As will be discussed in more detail below, there are currently many coil configurations for generating an inductively coupled plasma in a vacuum chamber for processing purposes. In at least most configurations, there can be capacitive coupling between the coil configuration and the plasma and the level of this capacitive coupling is related to the potential difference dropped across the coil configuration. Whilst such capacitive coupling can be beneficial in certain arrangements, there are also significant disadvantages and in particular it can lead to uncontrolled and undesired etching of surfaces within the chamber.

From one aspect the invention consisting an inductive coil assembly for plasma processing apparatus including a coil and an external screen characterised in that the coil is constituted by a plurality of coil portions and in that the assembly includes respective connecting means for connecting each portion in parallel with the others and to an RF source, the connecting means being formed such that the current flowing in any part of the coil other than a segment of a portion is balanced by current flowing in an opposite sense in an adjacent part.

Each coil assembly may be constituted by a plurality of adjacent segments which together define the inductive

coupling portion of a cylindrical coil. That is to say each segment may be an arc. Conveniently the segments may be in the form of strips such that the coil is effectively in the form of a cylinder or frustocone. In any of these cases the  
5 connecting means may include a pair of rings and the portions may bridge between the rings.

In an alternative arrangement each segment may be constituted on a loop so that segments together form an array corresponding to a generally planar, domed or curved  
10 coil. The array may be constituted so that the segments are those parts of the portions which are unbalanced and thus produce net field. These will include those which lie on the periphery of the array.

The connecting means may include co-axial connections  
15 and/or rings. The latter may constitute a screen.

A respective capacitor may be connected across each portion so that the capacitors are connected in parallel. An advantage of the distribution of these capacitors is that it reduces current crowding by distributing current more  
20 evenly throughout the RF structure.

From another aspect the invention consists in an inductive coil assembly for plasma processing apparatus including a coil characterised in that the coil is constituted by a plurality of coil segments connected in  
25 series to form a loop, each coil segment being separated from its neighbour by a series connected capacitor, and in that the assembly includes means for supplying RF power to the loop.

The power supply means may be connected across one of the capacitors or, alternatively, it may include a coil for inducing RF power in the loop, in which case the mid-point of each segment is preferably earthed.

5       The segments may be equal in length and the capacitor values may be such that they resonate with the segments so that the reactive voltage in each segment is cancelled out.

Although the invention has been defined above it is to be understood it includes any inventive combination of the  
10 features set out above or in the following description.

The invention may be performed in various ways and specific embodiments will now be described, by way of example, with reference to the accompanying drawings in which:

15       Figure 1 is a schematic illustration of the simplest known arrangement for generating an inductive coupled plasma;

Figure 2 is a schematic illustration of the magnetic field generated by the coil of Figure 1 at the peak of an RF  
20 cycle;

Figure 3 is a further magnetic field diagram indicating the affect of the introduction of a screen;

Figure 4 is a magnetic field diagram for a multiple turn coil;

25       Figure 5 is a similar diagram for an alternative coil;

Figure 6 is a diagram corresponding to that of Figure 5 with the coil in the form of a strip;

Figure 7 is the diagram illustrating the use of

segmented coils incorporating one aspect of the invention;

Figure 8 illustrates how a development of Figure 7 can be used so that a plurality of coil segments form a single coil assembly;

5        Figure 9 is a schematic, partially cut away, perspective view of the apparatus of Figure 8;

Figure 10 is a circuit diagram illustrating how power is fed into the arrangement of Figure 9;

10        Figure 11 shows an alternative wiring arrangement for the coil segments;

Figure 12 shows how the wiring arrangement of Figure 11 can be doubled up using a mirror image;

15        Figure 13 illustrates an arrangement in which a high voltage (capacitive) mode may be available for striking the plasma and a lower voltage mode used for sustaining the plasma;

Figure 14 illustrates a typical known spiral coil, which can be placed adjacent to a dielectric window as the diagrammatically illustrated in Figure 15;

20        Figure 16 is a schematic illustration of the equivalent arrangement according to the invention;

Figure 17 is an end view of the Figure 16 arrangement;

Figure 18 corresponds to Figure 17 but on this occasion the coil portions are hexagonal;

25        Figure 19 illustrates the connection to the power supply of a single hexagonal coil portion Figure 18;

Figures 20a - c indicate how a LC circuit is the equivalent of a circuit having a polarity of series

capacitors and a polarity of series coil portions;

Figure 21 illustrates how such a circuit could be configured by arcuate segments interconnected by capacitors to form a circular loop.

5        Figure 22 illustrates how such an arrangement can be fed by a matching circuit connected across one of the capacitors;

Figures 23 and 24 illustrated as a circuit diagram and schematically respectively an equivalent immersed coil  
10       arrangement fed inductively; and

Figure 25 is a detailed scrap view showing a practical embodiment of Figure 24.

Figure 1 illustrates the simplest arrangement for generating an inductively coupled plasma and comprises a  
15       single turn coil or loop 10 placed around a vacuum chamber which has a wall of a non-conductive material, such as glass or ceramic. Typically the chamber is evacuated and then filled, at low pressure (for example a few 10s mT) with an inert gas such as Argon. RF power is applied to the coil,  
20       which sets up an alternating magnetic field which penetrates the chamber. The magnetic field, in turn, will generate a circular electric field, which, if high enough, will ionise the gas and the conducting ring discharge will form just inside the chamber adjacent to the coil. The plasma then  
25       acts as the secondary of a transformer, in which the coil 10 is the primary.

The inductance and reflective resistance of the coil 10 will result in an RF voltage being developed around it.

This will therefore couple some energy to the plasma electrically due to the capacitance from the coil through the walls of the chamber. This can be of assistance in starting the discharge as the electrical field strength close to the end of the coil will be somewhat higher than the circumferential components. If electrical coupling is undesirable this can be screened using a Faraday cage, which is essentially transparent to the alternating magnetic field, but opaque to the electric field.

10 In Figure 2 the magnetic field of the coil 10 at the peak of the RF cycle is illustrated (ignoring the chamber). Inside the coil 10, the field is all in one direction, whilst outside it is in the opposite direction. If the coil is imagined in free space, then the field gradually dies  
15 away as it gets further away from the coil. However, if a screen 12 is introduced (see Figure 3) a current will be induced in the screen in the opposite direction to that in the coil, cancelling any external field. In most practical arrangements the screen 12 is required to avoid RF  
20 interference and will often be an approximately seamless cylindrical structure, such as the overall enclosure. Figure 4 illustrates how a multi-turn coil 10a can generate the same magnetic field pattern. Figure 5 illustrates a parallel equivalent 10b, whilst Figure 6 shows the coil in  
25 the form of a strip or split cylinder, in which the gaps between the turns in Figure 5 have essentially been removed.

The voltage needed to be applied to the coil 10 depends on the frequency of the power supply and the coil size and



is proportional to how many times the current loops around the area A. The voltage therefore increases with the number of loops or turns. All the magnetic field links through the outside area B and thus the current effectively loops around this also. The Applicants have realised that the area B can be broken up into fractions and therefore the voltage around each fraction will be less in proportion. Thus, as illustrated in Figure 7, the area B may be filled with 6 coil portions 13, which combine to produce an almost corresponding pattern. The voltage required on any coil portion 13 will be approximately one sixth of the voltage required on the equivalent coil 10. However, with circular coil portions 13 the area B is not perfectly filled and leakage can occur in between the coil portions, reducing the field which couples through the centre. This problem can be overcome by configuring the coil portions as shown in Figure 8 so that the coil portion 13 become segments or arcs 13a of the single coil 10. It will be noted that the leads 14 are arranged so that each input lead 14a lies immediately adjacent an output lead 14b, such that the adjacent pairs carry equal and opposite currents and are close to each other. This means that they do not generate any overall magnetic field and there is correspondingly no flux leakage. Adjacent pairs of leads 14a, 14b can be constituted by co-axial cable.

If, as is proposed by the Applicants, these coil portions 13 are connected in parallel, then the maximum voltage on each one will be the same and will be reduced

compared to the simple single turn coil 10 in proportion to the number of coil portions present. Thus, for example, with six coil portions, the voltage will only be one sixth. Each coil portion 13 carries the same current as the single  
5 turn coil 10, so that the total current will be six times this. The impedance has therefore dropped by a factor of 36. In general for a coil made up of N portions, the voltage is reduced by N, the overall current is increased by N and the impedance is reduced as  $N^2$ .

10 Figure 9 illustrates more fully a practical configuration which can be utilised to provide the arrangement shown in Figure 8.

Thus each segment 13a and its associated input and output leads 14a, 14b are formed from metal strip so that  
15 the segments 13a extend circumjacent the chamber 11 and the input and output leads of adjacent pairs of segments 13a extend radially outwards immediately adjacent to each other. The input and output leads extend through the screen 12 to present terminals 15 for connection to co-axial feed lines  
20 16 that extend from power input 17. Respective capacitors 18 are connected across the segments 13a. A circuit demonstrating this configuration is set out in Figure 10. The chamber 11 also has a lid 19 which incorporates an electrode 20 for forming an electric field within the  
25 chamber 11.

Experiment The apparatus illustrated in Figures 9 and 10 was tested using a six segment coil. The chamber comprised a 190mm borosilcate glass bell jar filled with

Argon to approximately 20mT. Initially a 200mm diameter single turn coil of height 15mm made of 1.2mm thick aluminium was placed around this. An overall screen aluminium cylinder of 300mm diameter was placed around the  
5 coil. 13.65MHz RF was supplied via a matching unit, one end of which was grounded. A fixed 100pF capacitor was placed across the coil to pass most of the circulating current. This and the L network were tuned to resonance.

A good match at 300 watts was obtained with a ring  
10 discharge struck inside the chamber. As the power was ramped up from zero a general faint glow at first appeared throughout the chamber due to electric field coupling. The ring discharge became more pronounced as the power was increased. Approximately 2,500V peak to peak was measured  
15 at the live end of the coil. The total tuning capacitance was approximately 300 pF.

The single turn was then replaced by the six segments 13a attached to the outer screen cylinder. These were connected in parallel via a ring main of co-axial cable 16.  
20 The three 1,000pF capacitors and three 2,000pF capacitors were distributed at the junctions of the ring main and coil segments. RF was applied by the same L network, some series inductance being required to obtain a good match. Total tuning capacitance approximated to 9,000pF. No discharge  
25 could be initiated so an additional plate electrode was placed on the chamber perspex lid. This was connected to an additional source of RF at 375kHz, which provided a very weak electrical discharge, but sufficient to strike the

13.65MHz inductively coupled plasma. The upper electrode was then turned off. Once the plasma was struck, 300W gave a visually similar ring discharge. Approximately 300 volts peak to peak was measured on the ring main.

5        Thus dividing the field generating area B up in this way enables the voltage to be reduced significantly as compared to the voltage requirements for a simple one turn coil and the arrangement of the input and output leads ensures there is no significant flux leakage. The operating  
10        voltages can thus to a great extent be chosen independent of the frequency required and the chamber size. The ability to reduce the voltage supplied, provides the apparatus designer with the ability to reduce or remove the unwanted electrical coupling, which arises from current designs.

15        Figure 11 illustrates a similar configuration, but wherein the input and output leads 14a, 14b have been rotated through 90°, whilst Figure 12 shows how two sets in mirror image could be employed.

      It should be noted that where the connecting means  
20        includes a ring or rings (e.g. 12a, 12b), then the ring or rings will function as a screen as a sufficient and opposite current will flow in the ring or rings as compared with the coil portions.

      Figure 13 is essentially similar to the arrangement in  
25        Figure 9, but an additional switch 21 is included so that the circuit can be switched between the illustrated position in which the segments 13a are connected in parallel and a second position 22 in which variable capacitor C allows

tuning of a common mode voltage into the segments 13a. Thus tuning capacitor C in conjunction with tuning capacitor C1 and conductor L may be adjusted to create a large voltage drop across C, thus causing a high voltage to appear on segments 13a. In the second position a high voltage can be applied to strike the plasma and once the plasma is struck, then the switch is moved into the illustrated position for "low voltage" operation. Additionally or alternatively the high common mode operation may also be used for sputtering the segments 13a or adjacent chamber parts.

The configurations described above all relate to coil assemblies which correspond to cylindrical coils. However, a large number of plasma processing apparatuses use "flat" coils that sit against dielectric windows or curved or dome like coils that sit over dome shaped windows. A typical example of a flat coil 23 is illustrated in Figures 14 and 15. The dielectric window is indicated at 24.

Figures 16 and 17 illustrate the Applicants' corresponding coil assembly and the theoretical basis for this is essentially exactly the same as set out in connection with Figure 7 above. Once again the circular portions 13 do not completely fill the area B and there is some flux leakage. The arrangement shown in Figure 18 overcomes this. Here the coil portions are essentially hexagonal. It will be noted that in addition to the leads being arranged in pairs that take oppositely flowing current, some facets of coil portions lie adjacent each other. In this arrangement the outer coil portions include

segments including unbalanced facets 13a at the periphery of the structure. This will allow a net field to be produced at the periphery. If a central coil portion(s) 13b is included, and is connected in the same phase direction and in parallel with the outer coil portions, then a greater  
 5 current is present on the inner coil portion e.g.

$V$  = voltage

$x$  = reactance of a facet of a coil portion

$I_o$  = current in the outer coil portion

10  $I_i$  = current in the inner coil portion

i.  $V = 3 \times I_o - x (I_i - I_o)$  outer coil portions

ii.  $V = 6 \times (I_i - I_o)$  inner coil portion

As the voltage on both inner and outer is the same:

$$6(I_i - I_o) = 3I_o - I_i + I_o$$

15  $7I_i = 10 I_o$

$$I_i = 1.43 I_o$$

The current flowing in the inner coil portion 13b will thus be greater than the adjacent outer coil portion facet 13c. As a result a reversed voltage drop will appear on the  
 20 adjacent outer coil portion facet. Thus the outer coil portion facet 13c adjacent an inner coil or coils portion 13b is also unbalanced and produces net field coupling into the plasma and hence effectively forms part of the coil.

Without affecting the generality of the invention such  
 25 flat coil arrangements may have any number of inner and outer coil portions including arrangements with no inner coil portions.

Figure 19 illustrates how any one of the coil portions

13 of Figure 18 can be connected to the power supply 17. It will be seen that a pair of plates 25, 26 are used to receive the respective input and output connections and the capacitors 18 in power supply 17 are connected across these  
5 plates.

Figures 20 to 25 relate to a different approach of the problem of voltage reduction. In a single coil arrangement, (see Figure 20(a)) there is typically, essentially, a capacitor C connected across an inductor L. As shown in  
10 Figure 20b the capacitor C can be made up of a number of capacitors connected in series and the inductance may be treated as a number of inductance portions in series (see Figure 20c).

The Applicants have realised that it is possible to  
15 locate the individual capacitors C between each coil portion and hence form a circuit as shown in Figure 21. It will now be seen that, once again, there are a number of individual segments 13a making up a single loop coil. Such an arrangement can be fed either, as illustrated in Figure 22,  
20 by using a power supply and matching unit 27 connected across one of the capacitors or, as illustrated in Figures 23 to 24, by making the coil segments 13 the secondary coil of a transformer 28. It has been determined that, whilst any point of the coil segments 13a may be earthed, it has  
25 been particularly advantageous if the mid points 30 of each coil segment 13a is earthed and the primary can in fact be constituted by a single strip loop 29 as shown in Figures 24 and 25.

When the mid-points are earthed, the inner coil could be viewed as a resonating Faraday cage and hence it will screen the electric field from the coupling coil. The use of a coupling coil 29 is particularly advantageous when the  
5 coil 10 for inductively coupling the plasma is to be immersed within the chamber 11.



Claims

1. An inductive coil assembly for plasma processing apparatus including a coil and an external screen characterised in that the coil is constituted by a plurality  
5 of coil portions each including an inductive segment and in that the assembly includes respective connecting means for connecting each portion in parallel with the others and to an RF source, the connecting means being formed such that the current flowing in any part of the coil other than the  
10 portions is balanced by current flowing in an opposite sense in an adjacent part.
2. An assembly as claimed in Claim 1, wherein each portion constitutes one of a plurality of adjacent segments which together define the inductive coupling portion of a  
15 generally cylindrical or frusto conical coil.
3. An assembly as claimed in Claim 2, wherein each segment is in the form of a strip such that the coil is effectively in the form of a cylinder or frustococone.
4. An assembly as claimed in Claim 2 or Claim 3, wherein  
20 the connecting means includes a pair of rings and the segments are connected between the rings.
5. An assembly as claimed in Claim 1, wherein each portion is constituted on a loop so that at least segments of the portions together form an array corresponding to a generally  
25 planar or curved coil.
6. An assembly as claimed in Claim 5, wherein the segments

include those parts of the portions which lie on the periphery of the array.

7. An assembly as claimed in claim 6 wherein the array includes a central coil which creates unbalanced current in  
5 adjacent segments.

8. An assembly as claimed in any one of Claims 2 to 7, wherein the connecting means include by coaxial connections.

9. An assembly as claimed in any one of Claims 2 to 8 further comprising a capacitor connected across each coil  
10 portions so that capacitors are connected in parallel to constitute a tuning capacitor for the assembly.

10. An inductive coil assembly for plasma processing apparatus including a coil characterised in that the coil is constituted by a plurality of coil segments connected in  
15 series to form a loop, each coil segment being separated from its neighbour by a series connected capacitor, and in that the assembly includes means for supplying RF power to the loop.

11. An assembly as claimed in Claim 10, wherein each  
20 segment is earthed.

12. An assembly as claimed in claim 11 wherein the midpoint of each segment is earthed.

13. An assembly as claimed in Claim 10 or Claim 11, wherein the segment are equal in length and the capacitors' values  
25 are such that the capacitors resonate with the portions so that the reactive voltage in each segments is cancelled out.

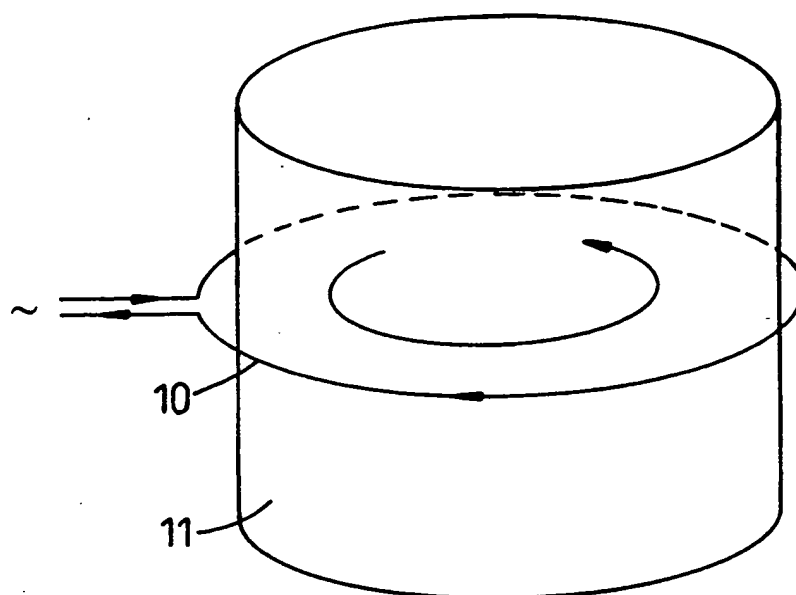
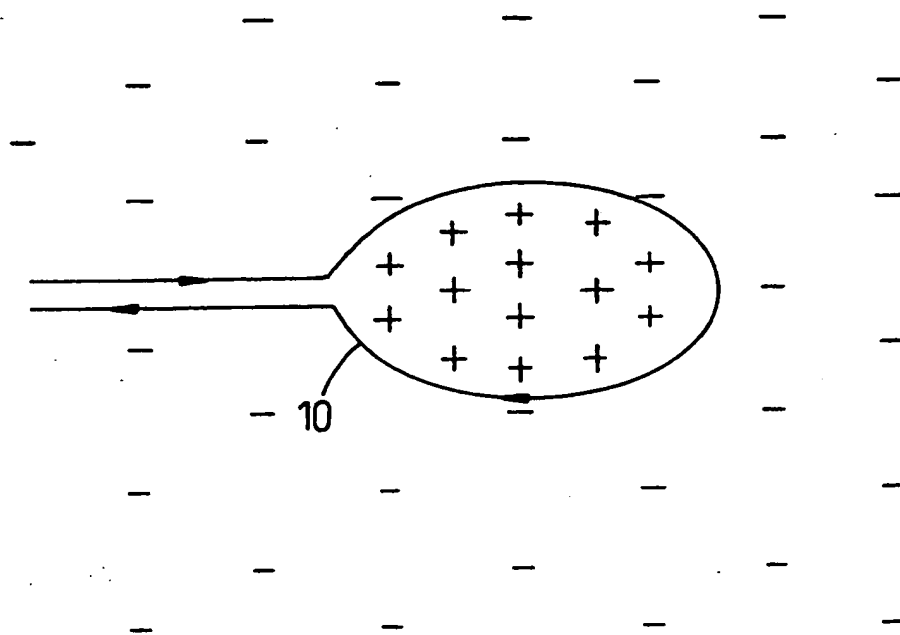
14. An assembly as claimed in any one of Claims 10 to 12

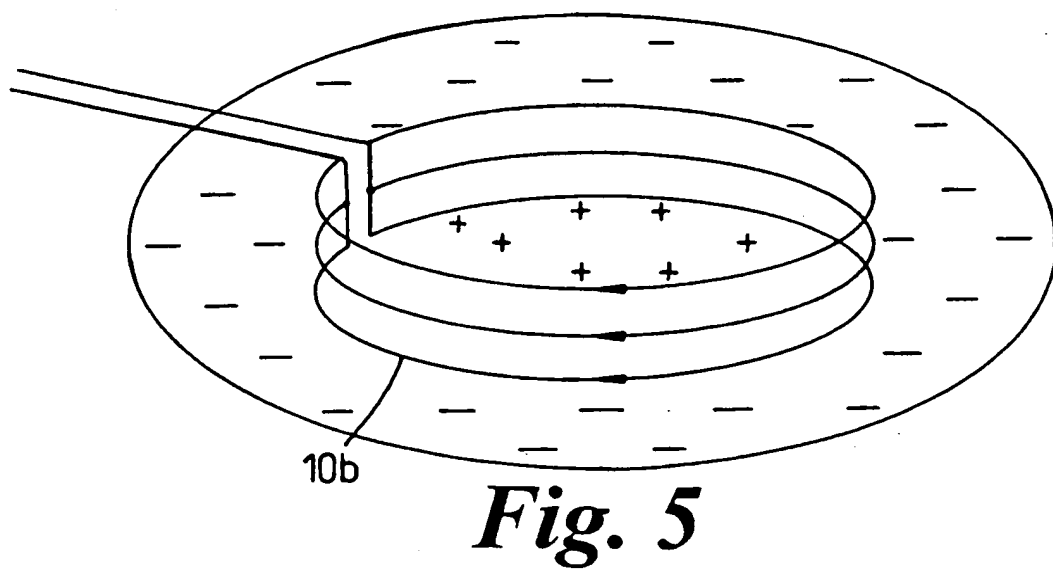
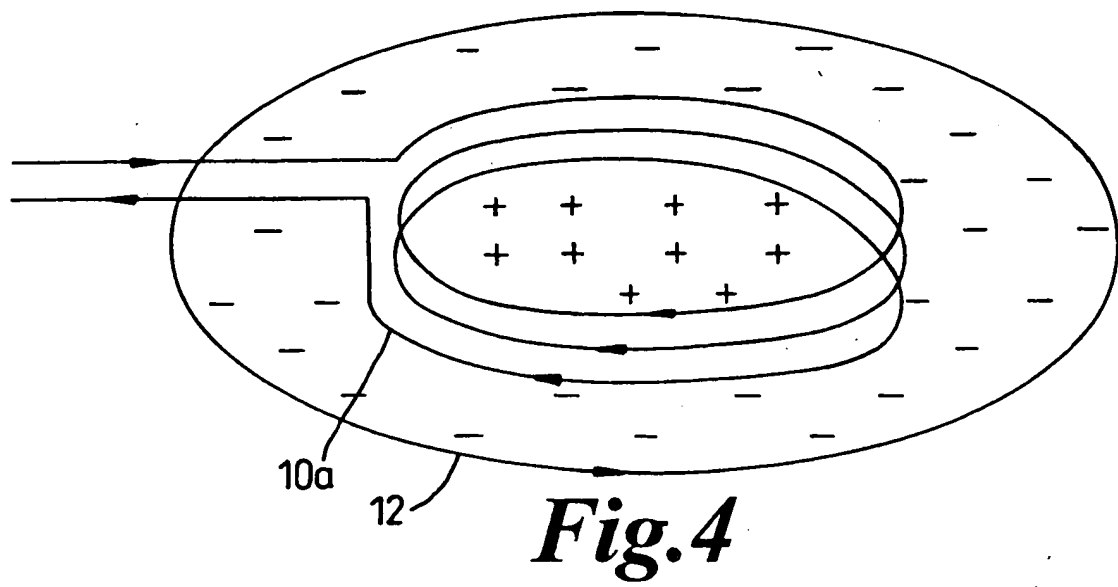
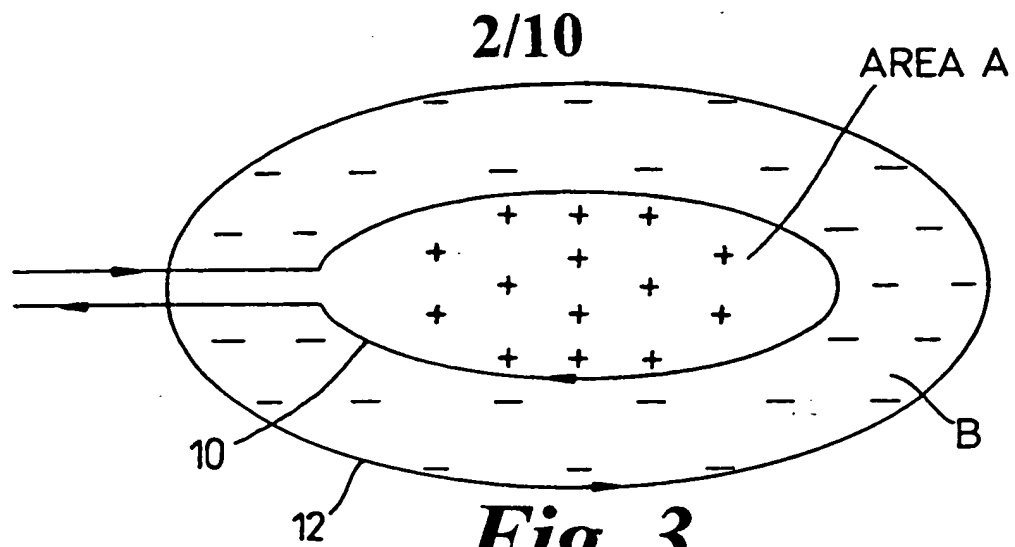
the capacitors.

15. A coil assembly as claimed in any one of Claims 10 to 12 wherein the power supply means include a primary coil for inducing RF power in the loop.

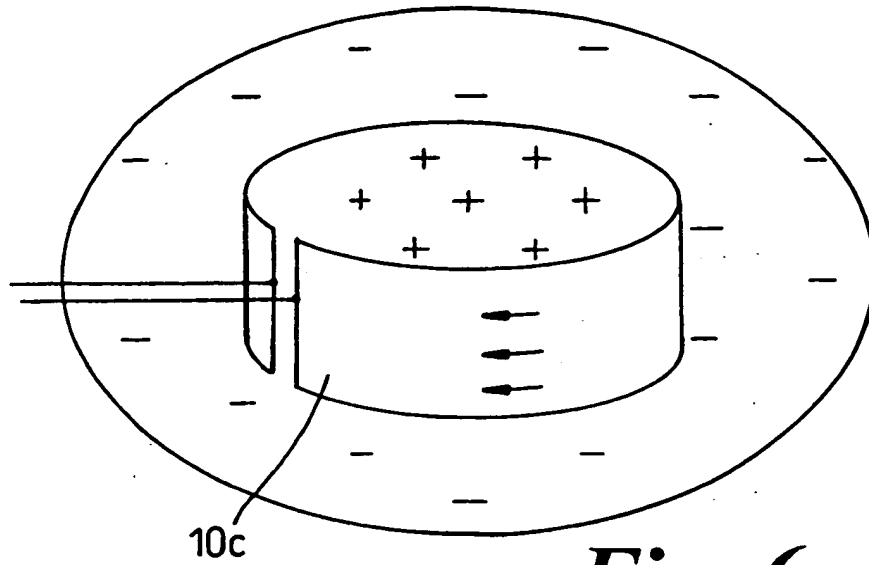
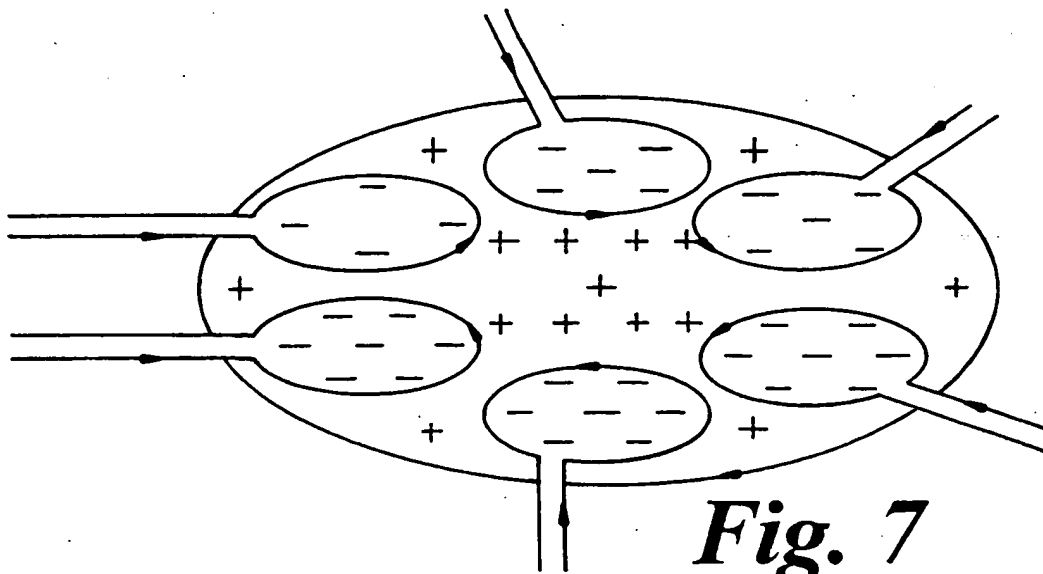
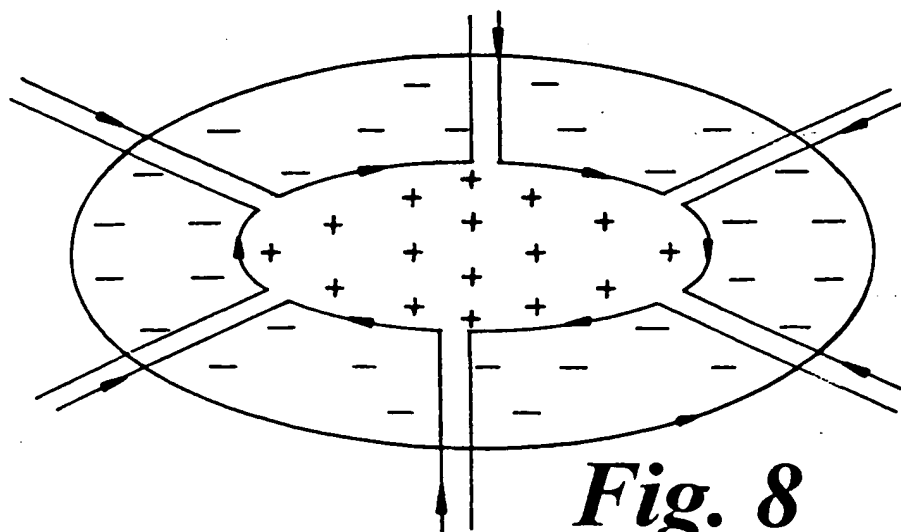
- 5 16. An inductive coil assembly substantially as herein before described with reference to the accompanying drawings.

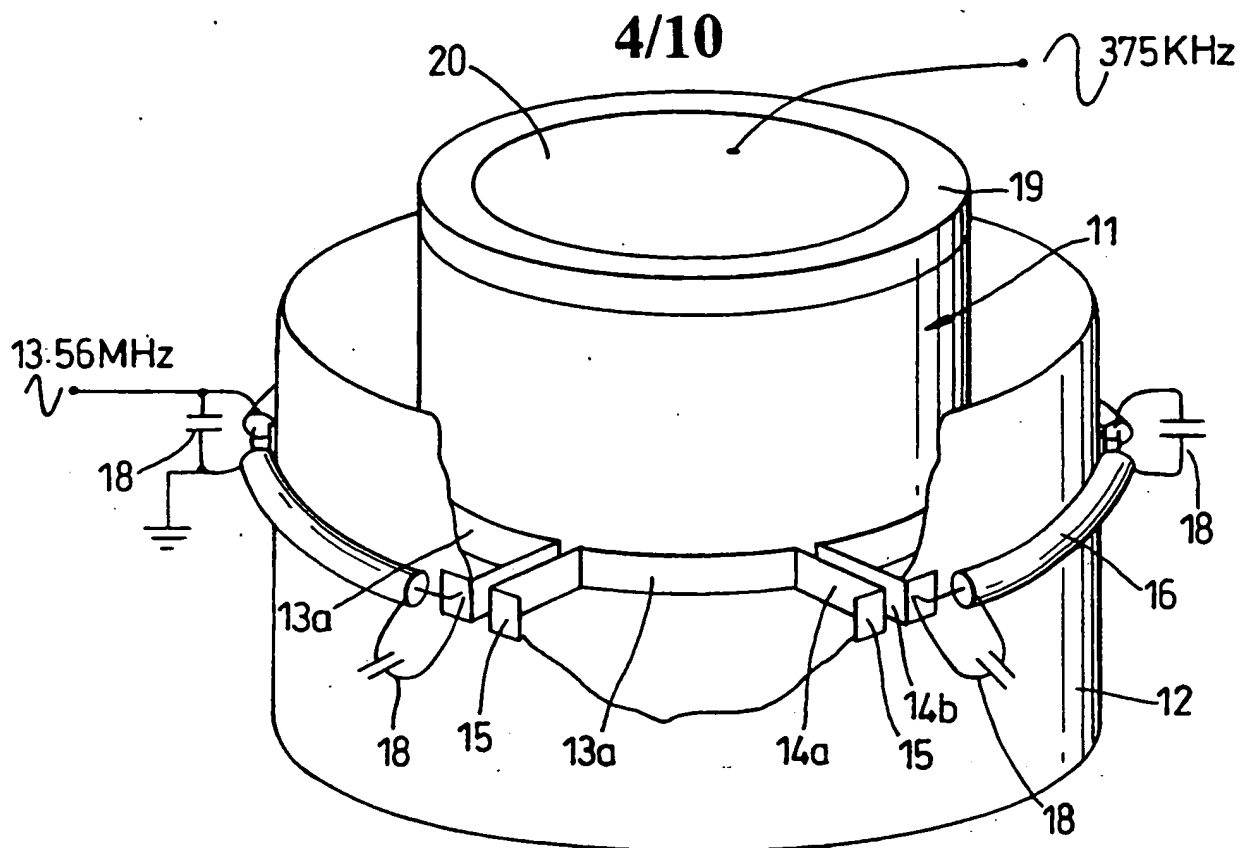
1/10

*Fig. 1**Fig. 2*

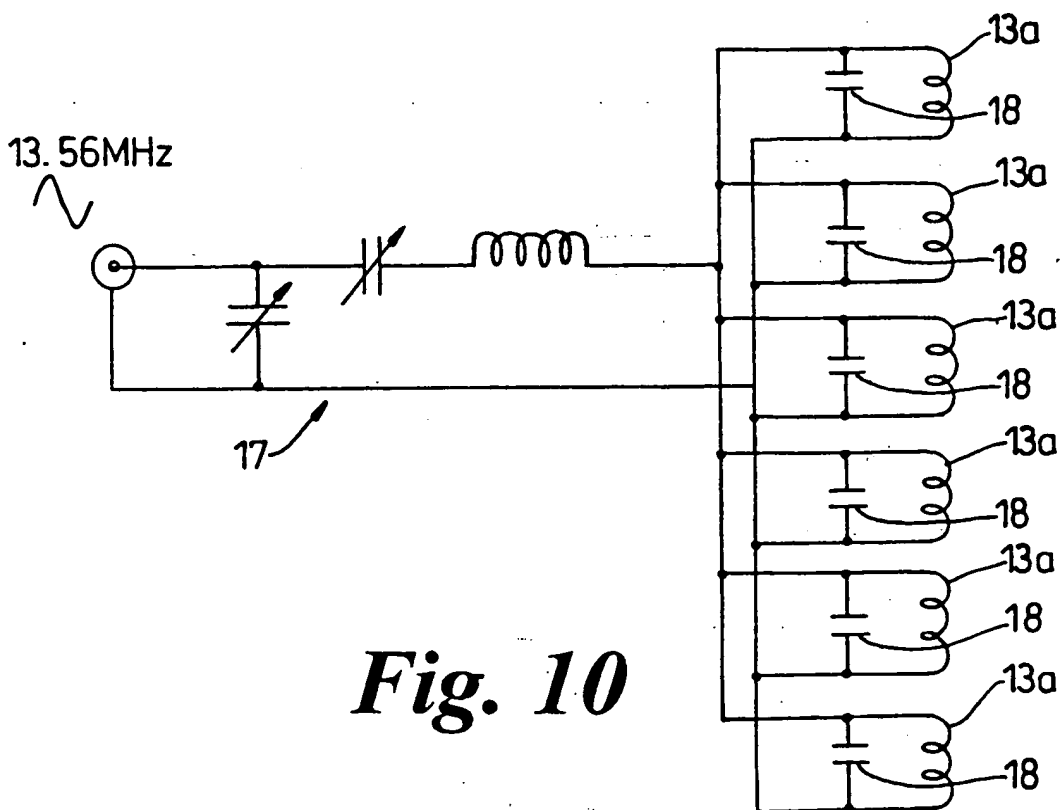


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*Fig. 6**Fig. 7**Fig. 8*

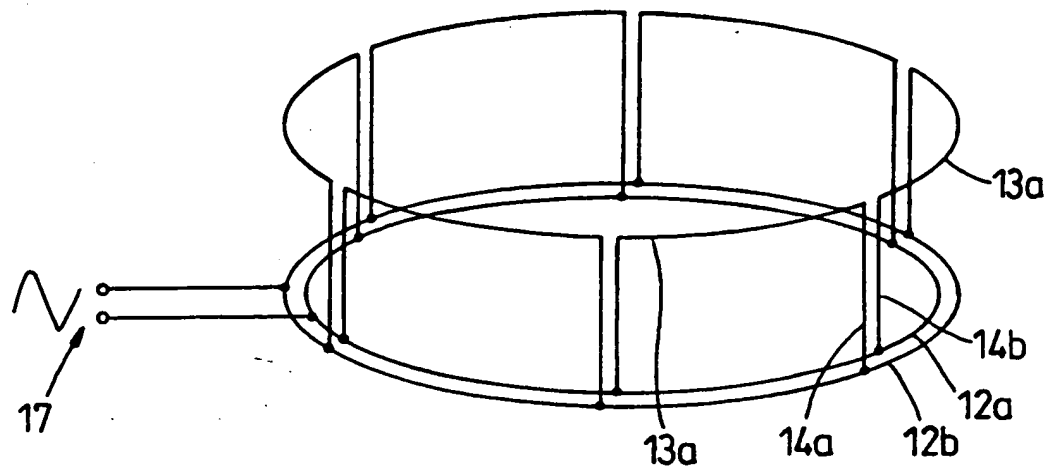
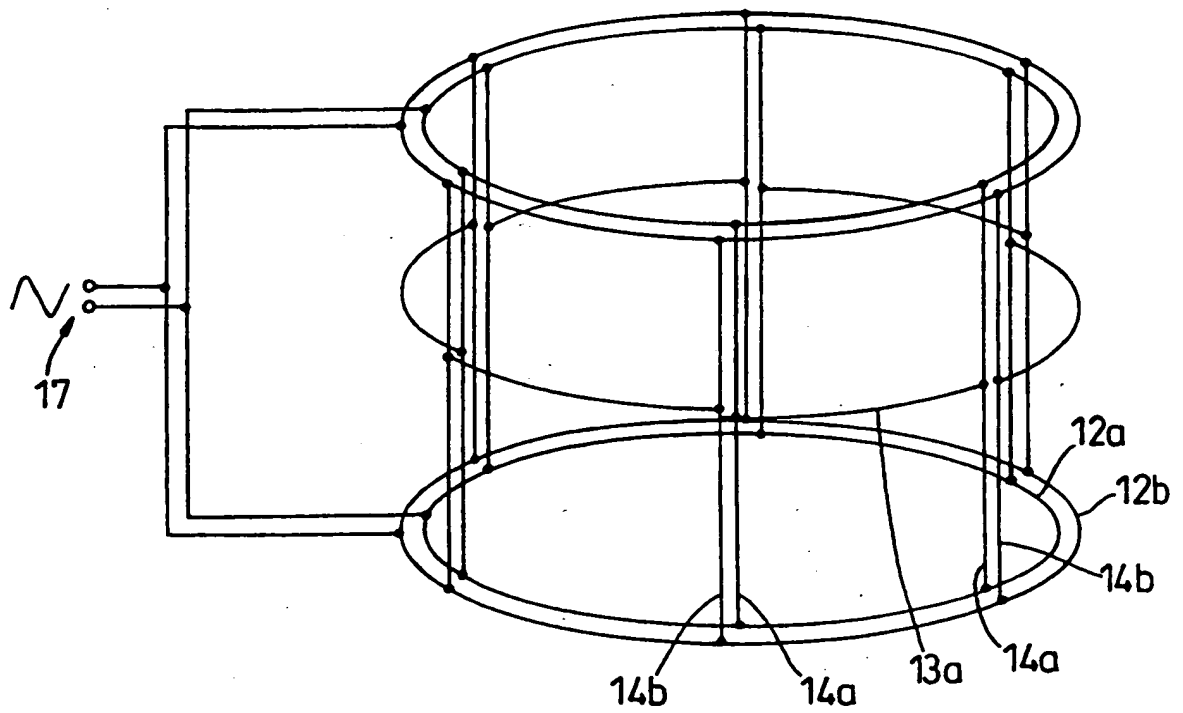


**Fig. 9**

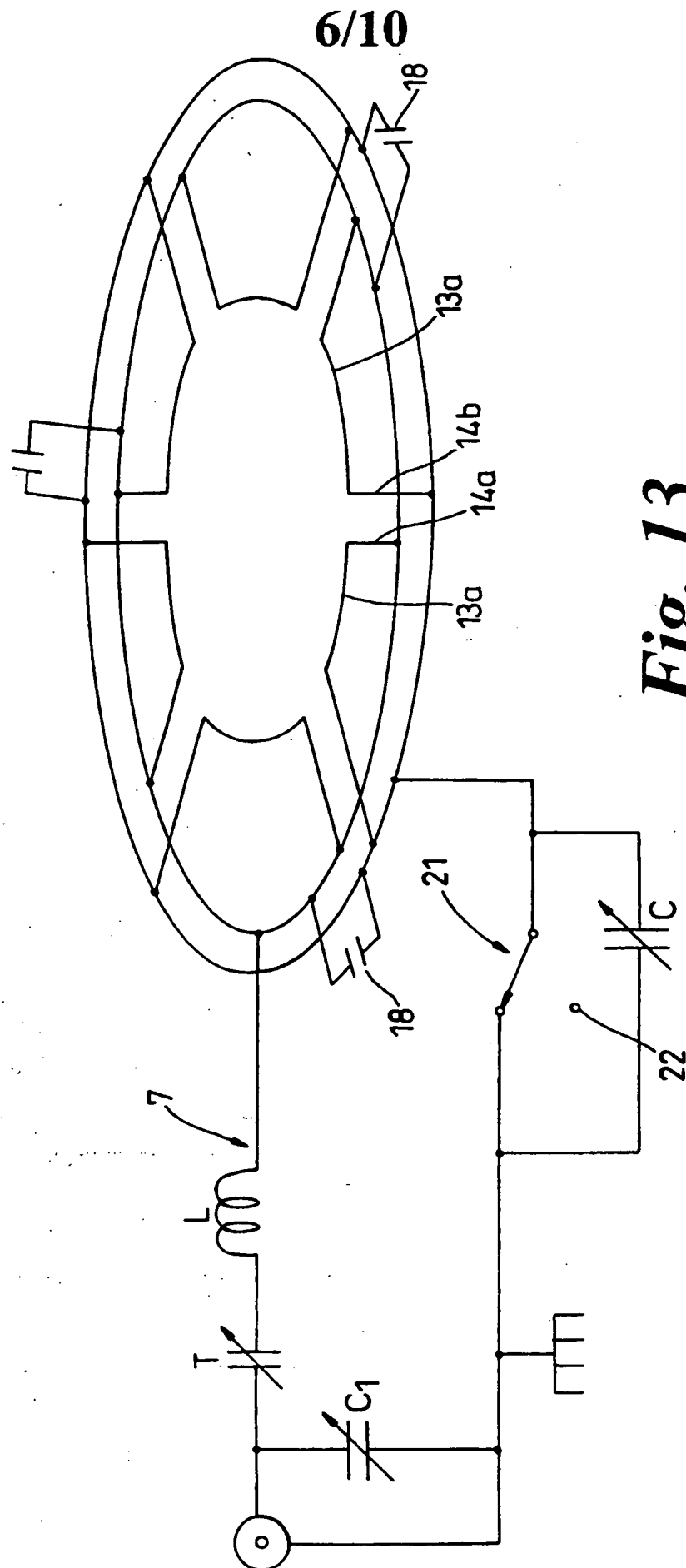


**Fig. 10**

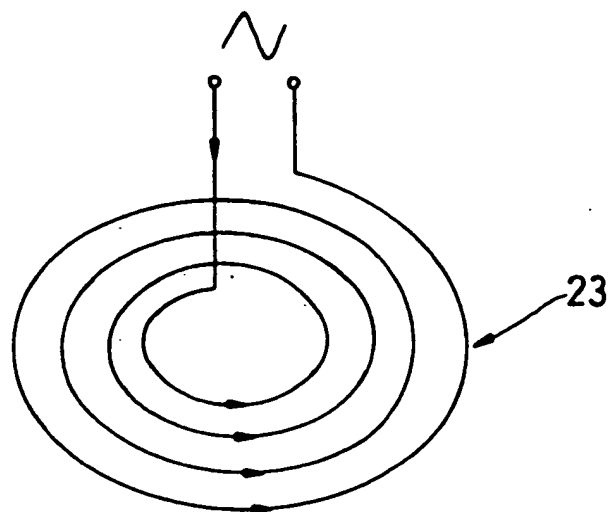
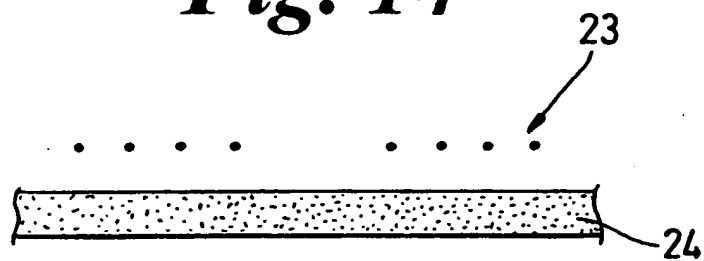
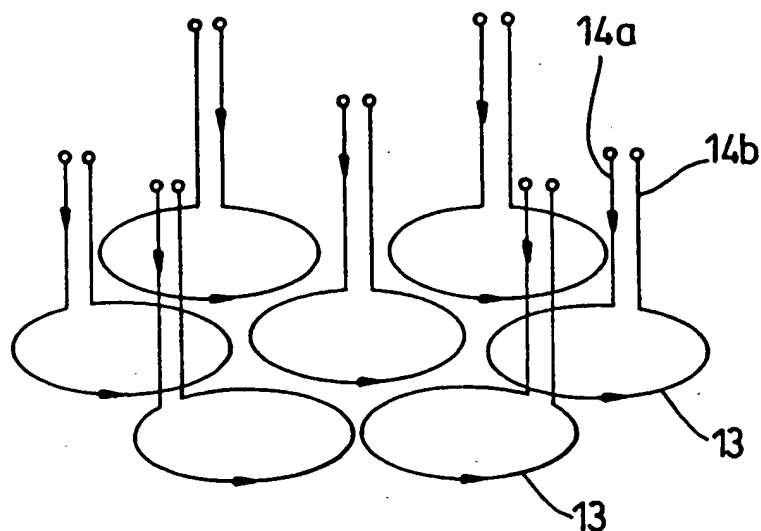
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*Fig. 11**Fig. 12*

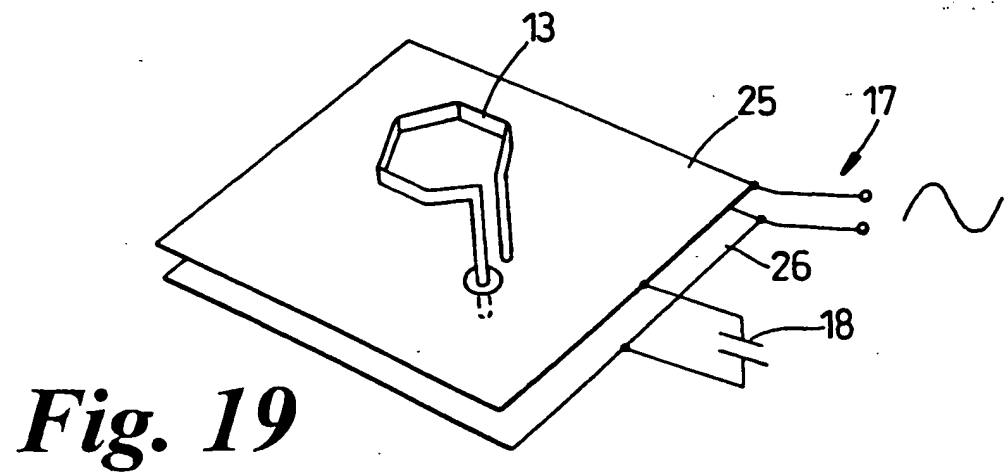
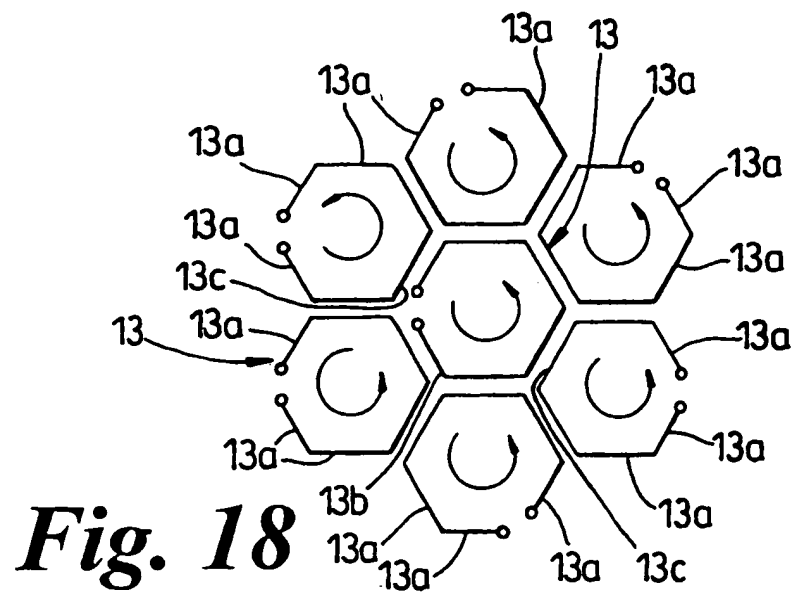
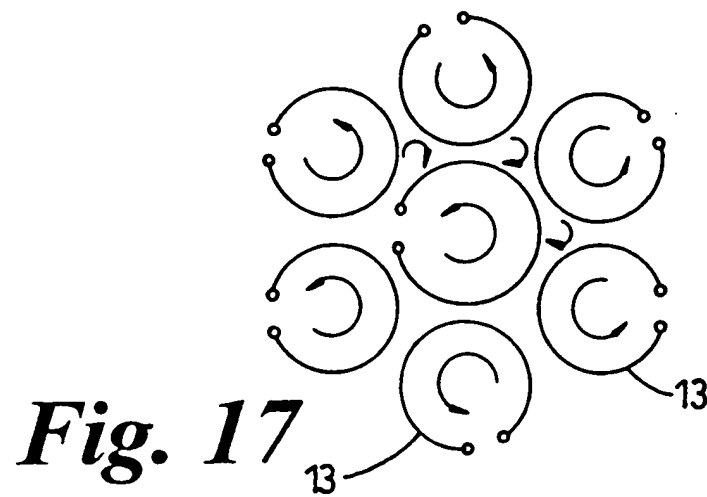




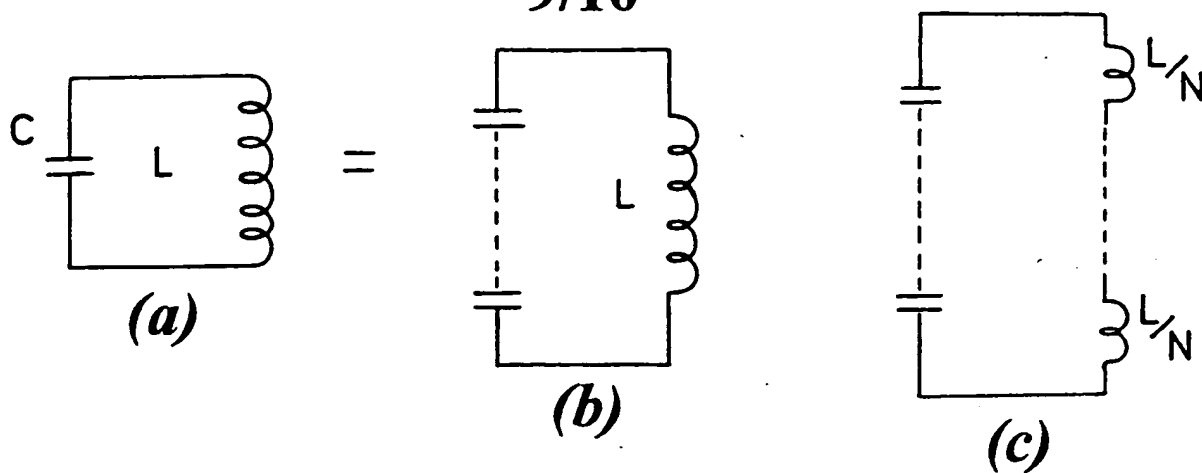
7/10

**Fig. 14****Fig. 15****Fig. 16**

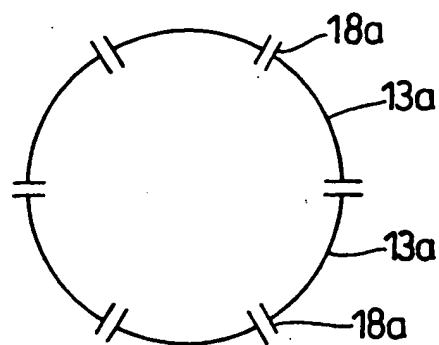
8/10



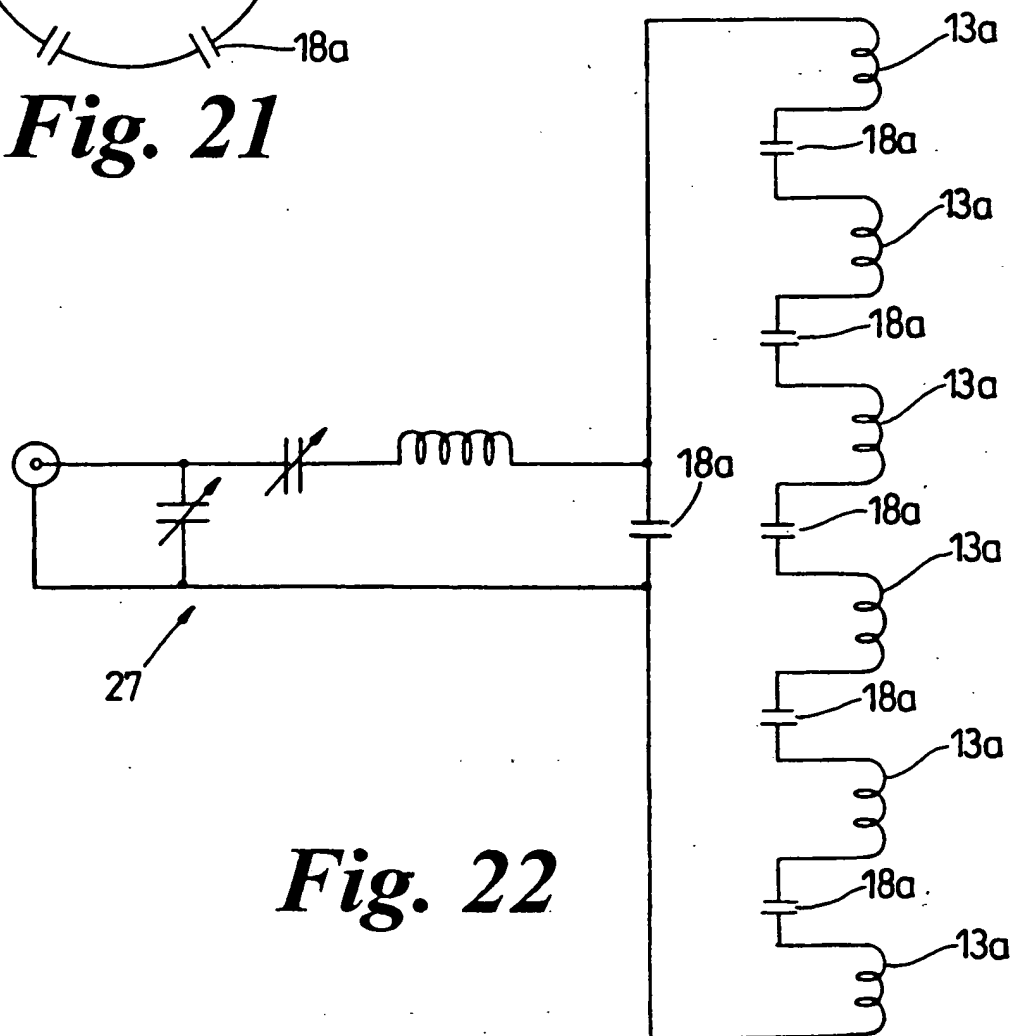
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**Fig. 20**

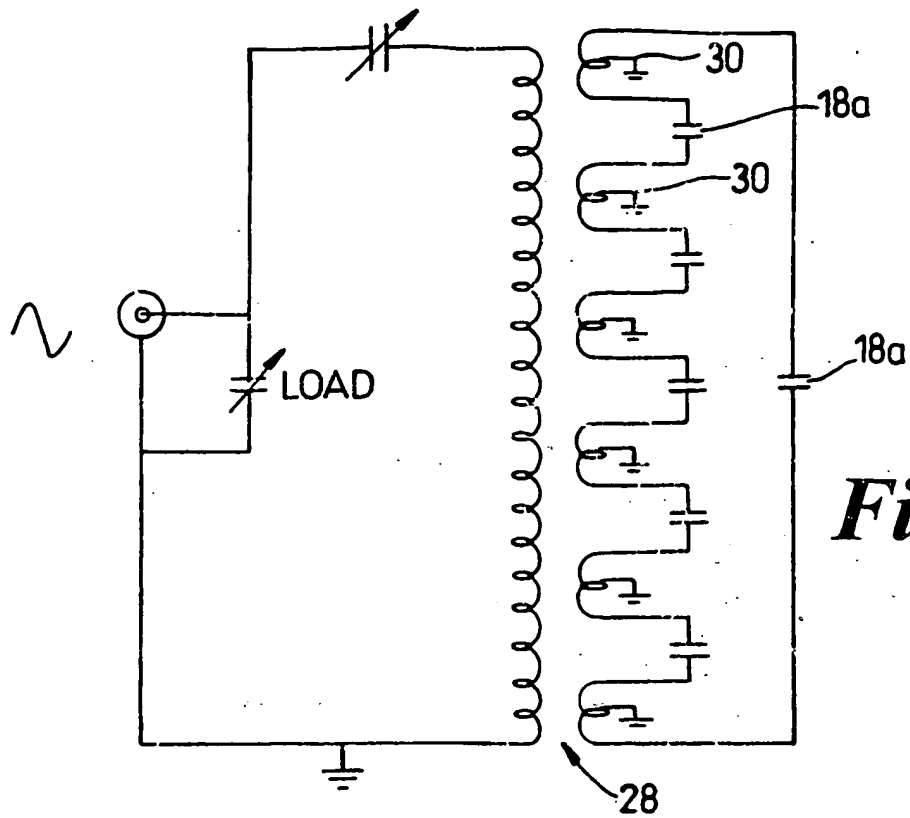
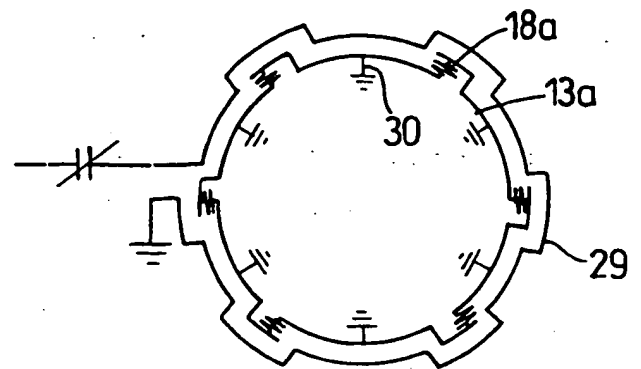
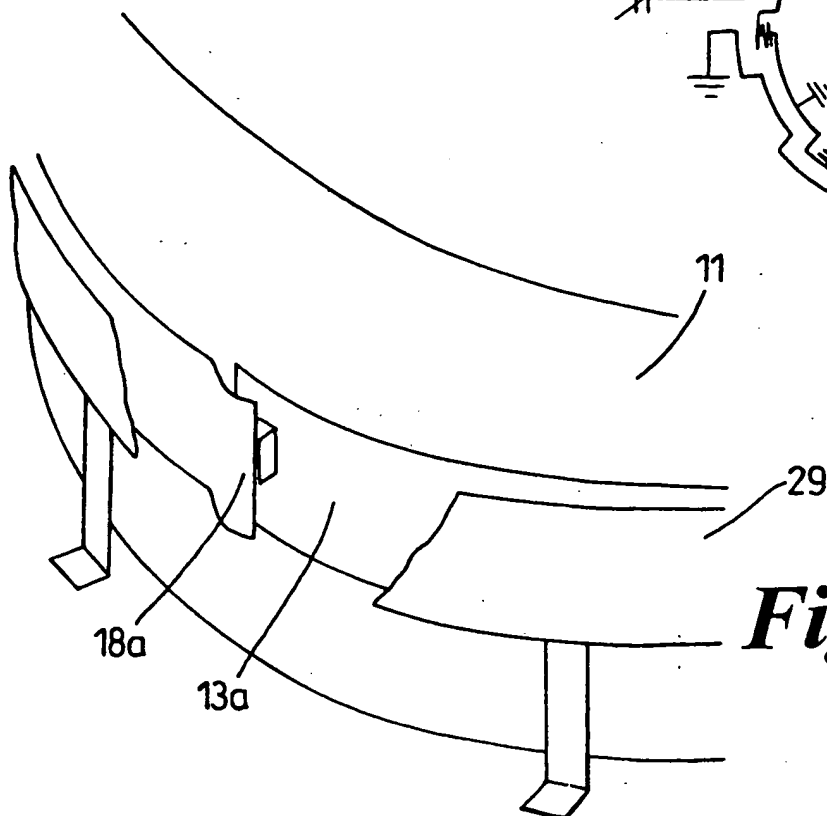


**Fig. 21**



**Fig. 22**

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**Fig. 23****Fig. 24****Fig. 25**

(19) World Intellectual Property Organization  
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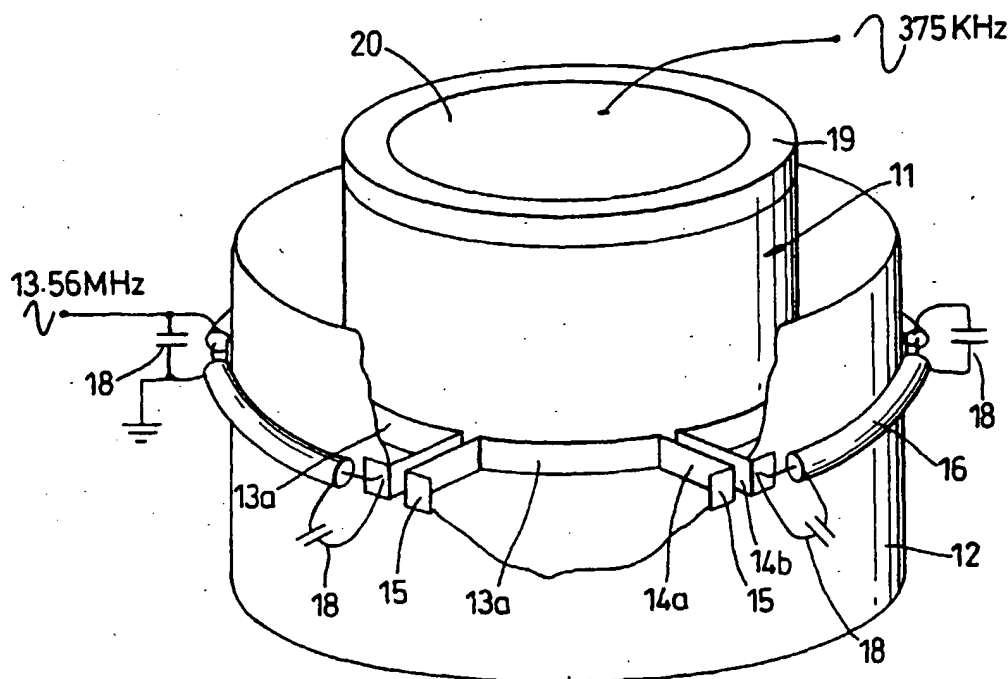
(43) International Publication Date  
22 June 2000 (22.06.2000)

PCT

(10) International Publication Number  
**WO 00/036632 A3**

- (51) International Patent Classification<sup>7</sup>: **H01J 37/32** (72) Inventor; and  
(75) Inventor/Applicant (for US only): **BENNETT, Paul, George** [GB/GB]; 6 Dighton Gate, Stoke Gifford, Bristol B5 34 (GB).
- (21) International Application Number: **PCT/GB99/04280**
- (22) International Filing Date:  
16 December 1999 (16.12.1999) (74) Agent: **WYNNE-JONES, LAINE & JAMES**; 22 Rodney Road, Cheltenham GL50 1JJ (GB).
- (25) Filing Language: English (81) Designated States (national): **DE, JP, US.**
- (26) Publication Language: English Published:  
— with international search report
- (30) Priority Data:  
9827778.3 17 December 1998 (17.12.1998) GB (88) Date of publication of the international search report:  
17 October 2002
- (71) Applicant (for all designated States except US): **TRIKON HOLDINGS LIMITED** [GB/GB]; Coed Rhedyn, Ringland Way, Newport, Gwent NP6 2TA (GB). For two-letter codes and other abbreviations, refer to the "Guidance Notes on Codes and Abbreviations" appearing at the beginning of each regular issue of the PCT Gazette.

(54) Title: **INDUCTIVE COIL ASSEMBLY**



(57) Abstract: This invention relates to inductive coil assemblies for plasma processing apparatus. The assembly includes a coil (10) and an external screen (12). The coil is constituted by a polarity of coil portions (13) and includes respective connecting means for connecting each portion (13) in parallel with the others and to RF source, the connecting means (14a, 14b) being formed such that current flowing in any part of the coil other than a portion is balanced by current flowing in an opposite sense in an adjacent part.

WO 00/036632 A3

## INTERNATIONAL SEARCH REPORT

International Application No.

PCT/GB 99/04280

A. CLASSIFICATION OF SUBJECT MATTER  
IPC 7 H01J37/32

According to International Patent Classification (IPC) or to both national classification and IPC

## B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

IPC 7 H01J

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practical, search terms used)

## C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category *	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
X	DE 44 03 125 A (FRAUNHOFER GES FORSCHUNG) 3 August 1995 (1995-08-03) column 2, line 10 - line 27 column 3, line 67 - column 4, line 23; figure 2	1, 2, 5
X	US 5 231 334 A (PARANJPE AJIT P) 27 July 1993 (1993-07-27) column 3, line 20 - column 5, line 60; figures	10, 13
A	WO 96 18208 A (LAM RES CORP) 13 June 1996 (1996-06-13) abstract; figures	1
A	EP 0 651 427 A (CENTRAL RESEARCH LAB LTD) 3 May 1995 (1995-05-03) abstract; figures	1, 5
	-/-	

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Date of the actual completion of the international search

12 April 2000

Date of mailing of the international search report

19/04/2000

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## INTERNATIONAL SEARCH REPORT

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## C.(Continuation) DOCUMENTS CONSIDERED TO BE RELEVANT

Category *	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
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